

# FDS6064N3

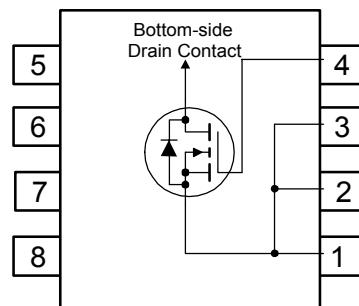
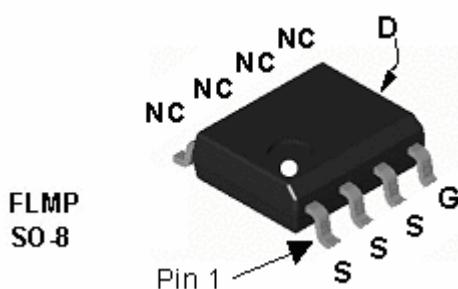
## 20V N-Channel PowerTrench® MOSFET

### General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{DS(ON)}$  in a small package.

### Applications

- Synchronous rectifier
- DC/DC converter
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size



### Absolute Maximum Ratings

$T_A=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain-Source Voltage	20	V
$V_{GSS}$	Gate-Source Voltage	$\pm 8$	
$I_D$	Drain Current – Continuous – Pulsed	23	A
		60	
$P_D$	Power Dissipation (Note 1a)	3.0	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

### Thermal Characteristics

$R_{QJA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	40	$^\circ\text{C}/\text{W}$
$R_{QJC}$	Thermal Resistance, Junction-to-Case	0.5	

### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS6064N3	FDS6064N3	13"	12mm	2500 units

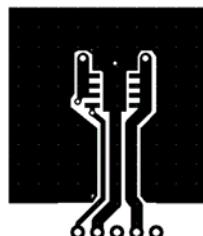
## Electrical Characteristics

$T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain–Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	20			V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$		11		$\text{mV}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 16 \text{ V}$ , $V_{\text{GS}} = 0 \text{ V}$			1	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate–Body Leakage, Forward	$V_{\text{GS}} = 8 \text{ V}$ , $V_{\text{DS}} = 0 \text{ V}$			100	nA
$I_{\text{GSSR}}$	Gate–Body Leakage, Reverse	$V_{\text{GS}} = -8 \text{ V}$ , $V_{\text{DS}} = 0 \text{ V}$			-100	nA
<b>On Characteristics</b> (Note 2)						
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250 \mu\text{A}$	0.4	0.6	1.5	V
$\frac{\Delta V_{\text{GS}(\text{th})}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$		-3		$\text{mV}/^\circ\text{C}$
$R_{\text{DS}(\text{on})}$	Static Drain–Source On–Resistance	$V_{\text{GS}} = 4.5 \text{ V}$ , $I_D = 23 \text{ A}$ $V_{\text{GS}} = 2.5 \text{ V}$ , $I_D = 22 \text{ A}$ $V_{\text{GS}} = 1.8 \text{ V}$ , $I_D = 18 \text{ A}$ $V_{\text{GS}} = 4.5 \text{ V}$ , $I_D = 23 \text{ A}$ , $T_J = 125^\circ\text{C}$		3.4 3.8 4.9 4.5	4 5 7 8	$\text{m}\Omega$
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}} = 5 \text{ V}$ , $I_D = 23 \text{ A}$		179		S
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 10 \text{ V}$ , $V_{\text{GS}} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$		7191		pF
$C_{\text{oss}}$	Output Capacitance			1403		pF
$C_{\text{rss}}$	Reverse Transfer Capacitance			703		pF
$R_G$	Gate Resistance	$V_{\text{GS}} = 15 \text{ mV}$ , $f = 1.0 \text{ MHz}$		1.2		$\Omega$
<b>Switching Characteristics</b> (Note 2)						
$t_{\text{d(on)}}$	Turn–On Delay Time	$V_{\text{DD}} = 10 \text{ V}$ , $I_D = 1 \text{ A}$ , $V_{\text{GS}} = 4.5 \text{ V}$ , $R_{\text{GEN}} = 6 \Omega$		22	35	ns
$t_r$	Turn–On Rise Time			22	35	ns
$t_{\text{d(off)}}$	Turn–Off Delay Time			153	245	ns
$t_f$	Turn–Off Fall Time			77	123	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 10 \text{ V}$ , $I_D = 23 \text{ A}$ , $V_{\text{GS}} = 4.5 \text{ V}$		70	98	nC
$Q_{\text{gs}}$	Gate–Source Charge			10		nC
$Q_{\text{gd}}$	Gate–Drain Charge			15		nC
<b>Drain–Source Diode Characteristics and Maximum Ratings</b>						
$I_s$	Maximum Continuous Drain–Source Diode Forward Current				2.5	A
$V_{\text{SD}}$	Drain–Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}$ , $I_s = 2.5 \text{ A}$ (Note 2)		0.6	1.2	V
$t_{\text{rr}}$	Diode Reverse Recovery Time	$I_F = 23 \text{ A}$ , $d_I/d_t = 100 \text{ A}/\mu\text{s}$		43		nS
$Q_{\text{rr}}$	Diode Reverse Recovery Charge			55		nC

Notes:

1.  $R_{\text{IJ,A}}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\text{IJ,C}}$  is guaranteed by design while  $R_{\text{OC,A}}$  is determined by the user's board design.



a) 40°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper

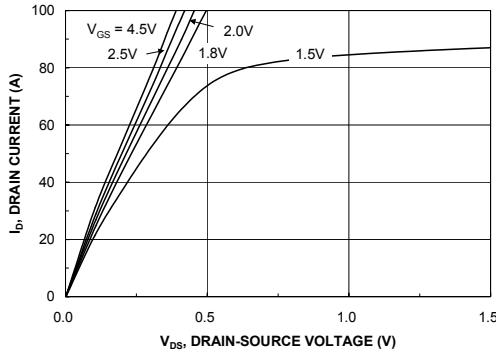


b) 85°C/W when mounted on a minimum pad of 2 oz copper

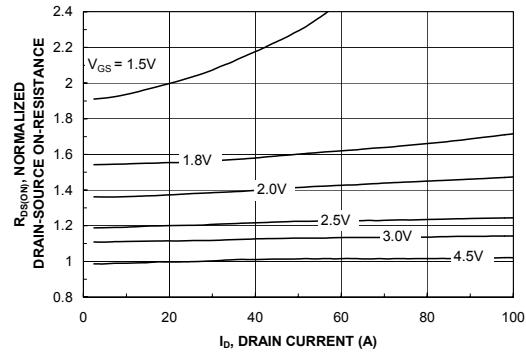
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

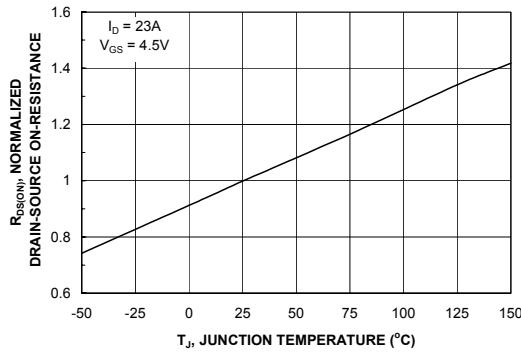
## Typical Characteristics



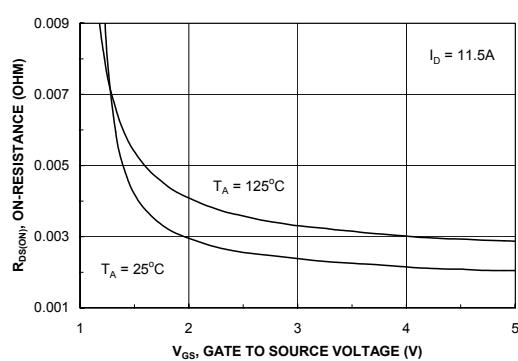
**Figure 1.** On-Region Characteristics.



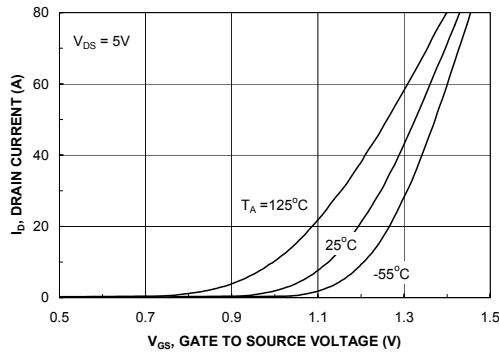
**Figure 2.** On-Resistance Variation with Drain Current and Gate Voltage.



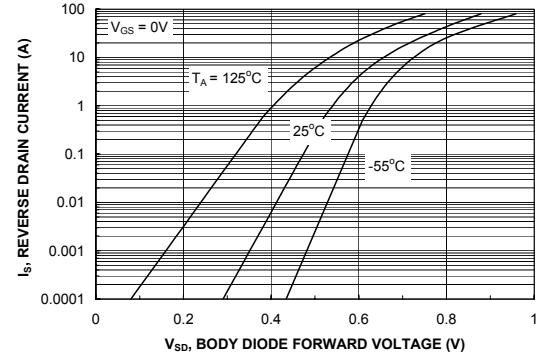
**Figure 3.** On-Resistance Variation with Temperature.



**Figure 4.** On-Resistance Variation with Gate-to-Source Voltage.

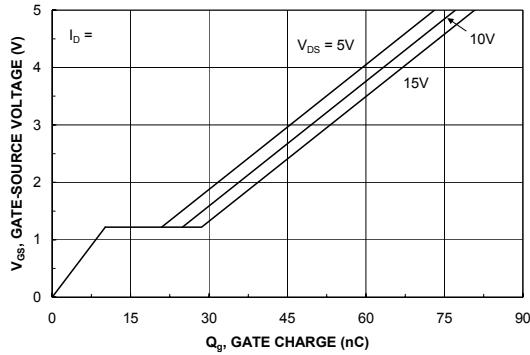


**Figure 5.** Transfer Characteristics.

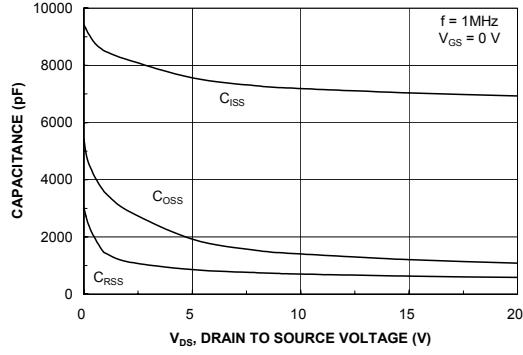


**Figure 6.** Body Diode Forward Voltage Variation with Source Current and Temperature.

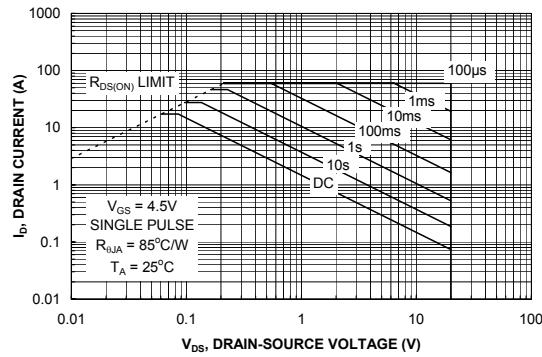
## Typical Characteristics



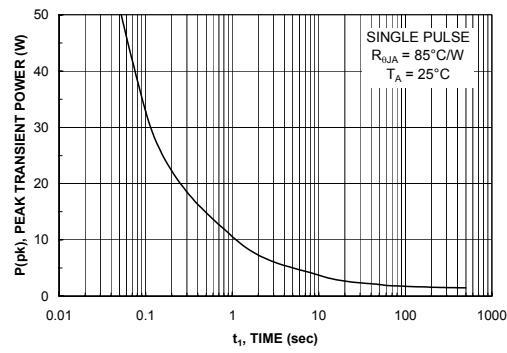
**Figure 7. Gate Charge Characteristics.**



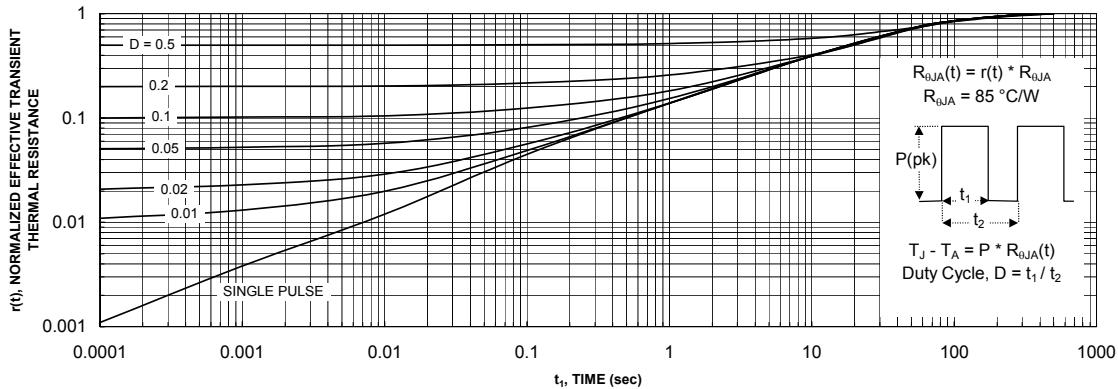
**Figure 8. Capacitance Characteristics.**



**Figure 9. Maximum Safe Operating Area.**



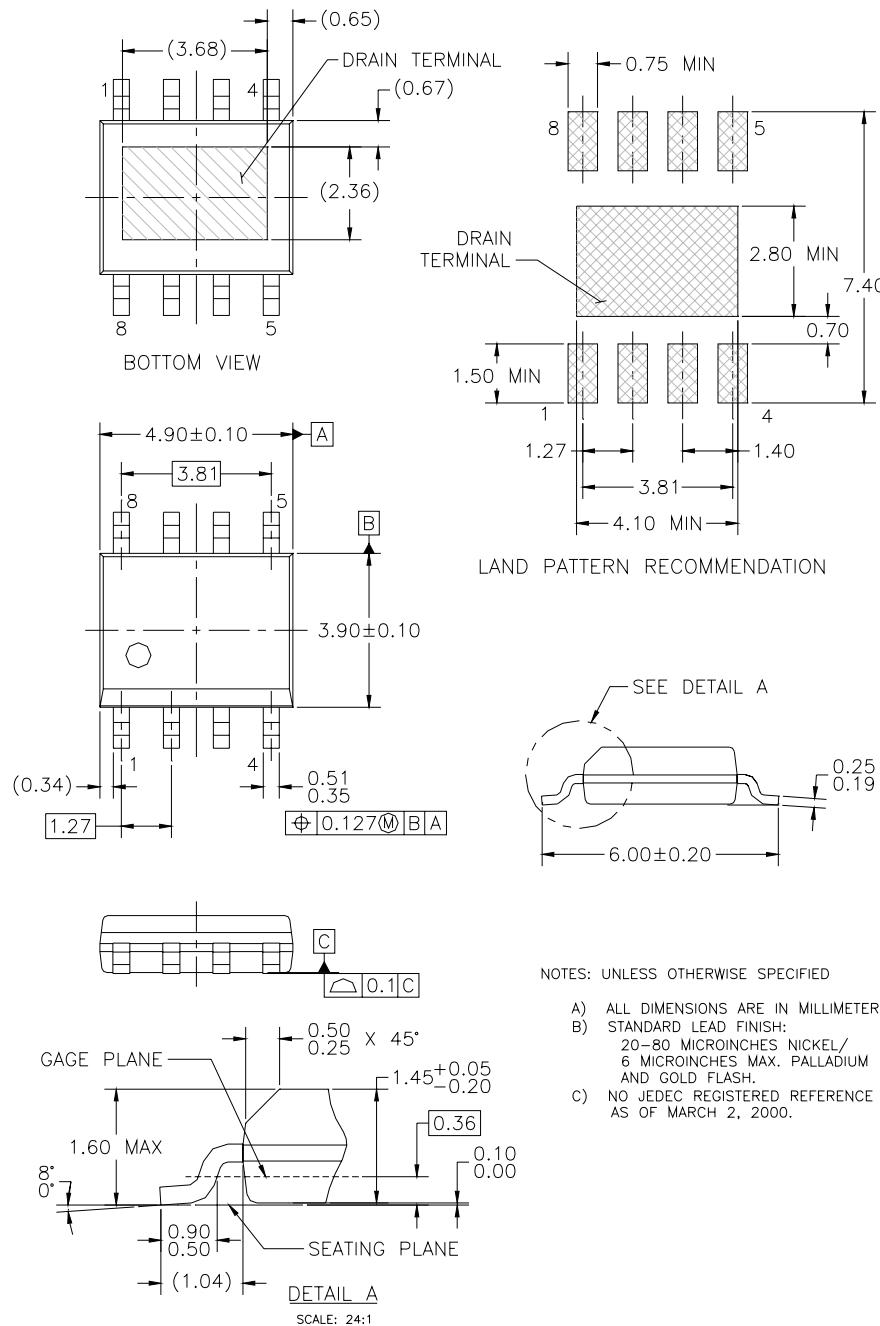
**Figure 10. Single Pulse Maximum Power Dissipation.**



**Figure 11. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1b.  
Transient thermal response will change depending on the circuit board design.

## Dimensional Outline and Pad Layout



NOTES: UNLESS OTHERWISE SPECIFIED

- A) ALL DIMENSIONS ARE IN MILLIMETERS.
  - B) STANDARD LEAD FINISH:  
20-80 MICROINCHES NICKEL/  
6 MICROINCHES MAX. PALLADIUM  
AND GOLD FLASH.
  - C) NO JEDEC REGISTERED REFERENCE  
AS OF MARCH 2, 2000

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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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